



承 认 书

SPECIFICATION FOR APPROVAL

客户名称: Customer _____

货 名: Description SMD 7050 XO CMOS 石英晶体振荡器

客户料号: Part No _____

物料编号: Code No O7533880155033

频 率: Frequency 33.880MHz

日 期: Date 2020-09-22

备 注: RoHS compliance with Directive (EU) 2015/863

制作(Prepare by)	检查(Check by)	批准 (Approve by)
郭静	甘瑛	张刚

客户批准 Approve by customer	
批准日期 Approval date	

Add:广东省深圳市华发北路桑达工业区桑达雅苑 7P

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■ ELECTRICAL SPECIFICATIONS

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature : $25\pm 5^{\circ}\text{C}$

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : $25\pm 3^{\circ}\text{C}$

Relative humidity : 40%~70%

Measure equipment

Electrical characteristics measured by MD 37WX-05M or equivalent.

Crystal cutting type

The crystal is using AT CUT (thickness shear mode).

■ Electrical characteristics

Frequency

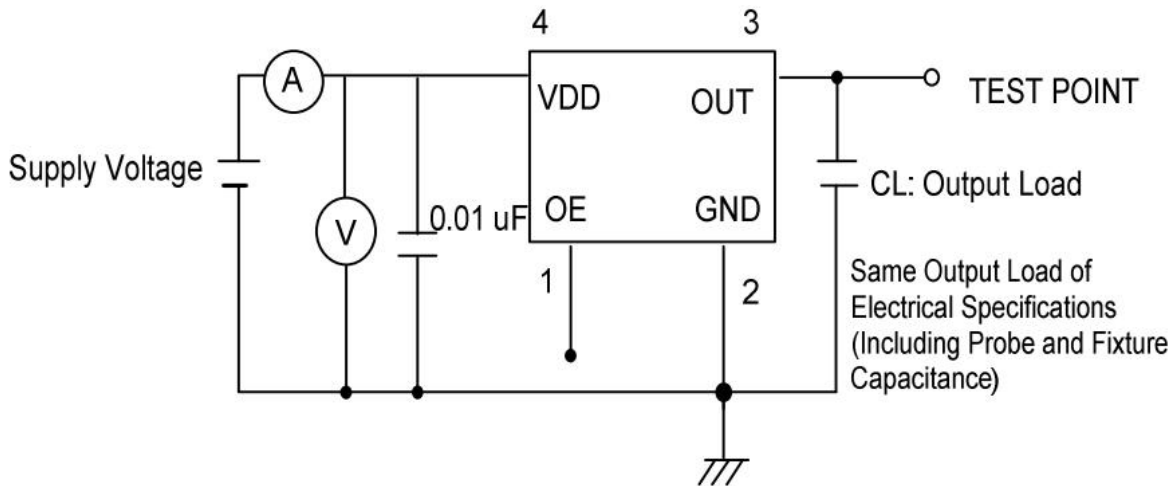
	Parameters	Symbol	Electrical Spec.				Notes
			Min.	Typ.	Max.	Units	
1	Nominal Frequency	-	33.880			MHz	-
2	Frequency Stability	-	± 50			ppm	-
3	Operating Temperature	Topr	-40	25	85	$^{\circ}\text{C}$	-
4	Storage Temperature	Tstg	-55	~	125	$^{\circ}\text{C}$	-
5	Supply Voltage	VDD	$3.3 \pm 10\%$			V	-
6	Input Current	Icc	-	-	20	mA	-
7	Enable Control	-	Yes			-	Pad 1
8	Output Load : CMOS	CL	15			pF	-
9	Output Voltage High	VoH	90%Vdd	-	-	V	-
10	Output Voltage Low	VoL	-	-	10%Vdd	V	-
11	Rise Time	Tr	-	-	10	ns	10%→90%VDD Level
12	Fall Time	Tf	-	-	10	ns	90%→10%VDD Level
13	Symmetry (Duty ratio)	TH/T	45	~	55	%	-
14	Start-up Time	Tosc	-	-	10	ms	-
15	Enable Voltage High	Vhi	70%Vdd	-	-	V	-
16	Disable Voltage Low	Vlo	-	-	30%Vdd	V	-
17	Aging	-	± 3			ppm/yr.	1st. Year at 25°C
18	Output Disable Delay Time	T off	-	-	150	μS	-
19	Output Enable Delay Time	T on	-	-	150	μS	-

■ TEST DIAGRAM

Control input (output enable/disable)

Logic 1 or open on pad 1: Oscillator output

Logic 0 on pad 1 : Disable output to high impedance

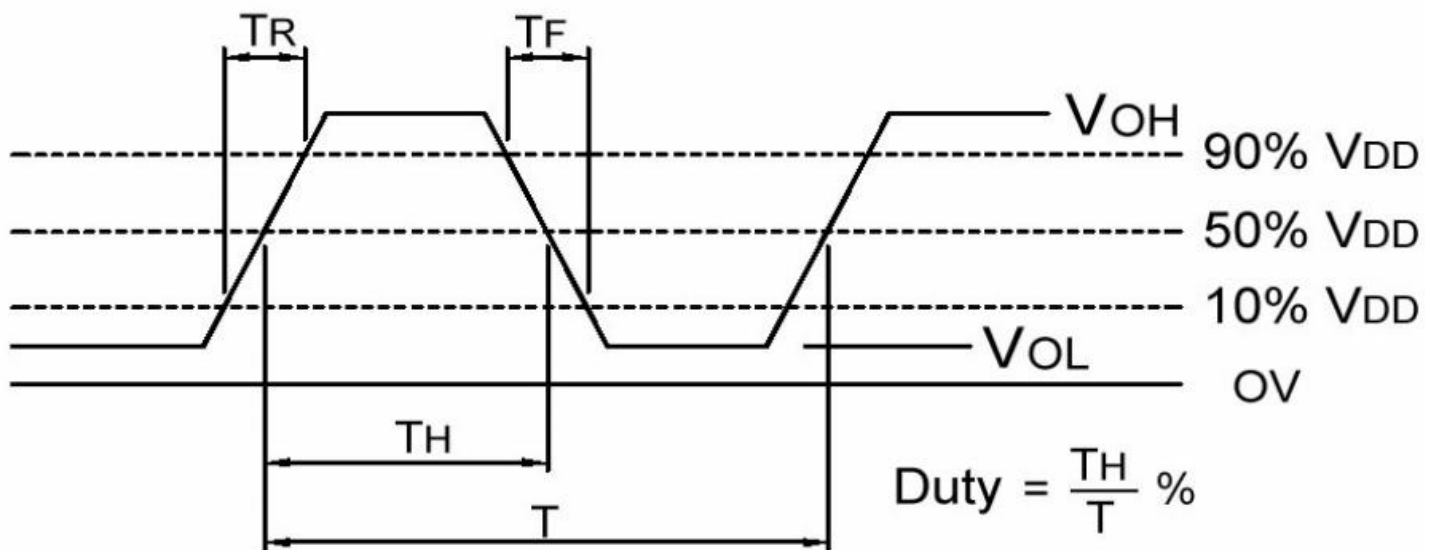


■ WAVEFORM CONDITIONS

Waveform measurement system

should have a min. bandwidth of 5

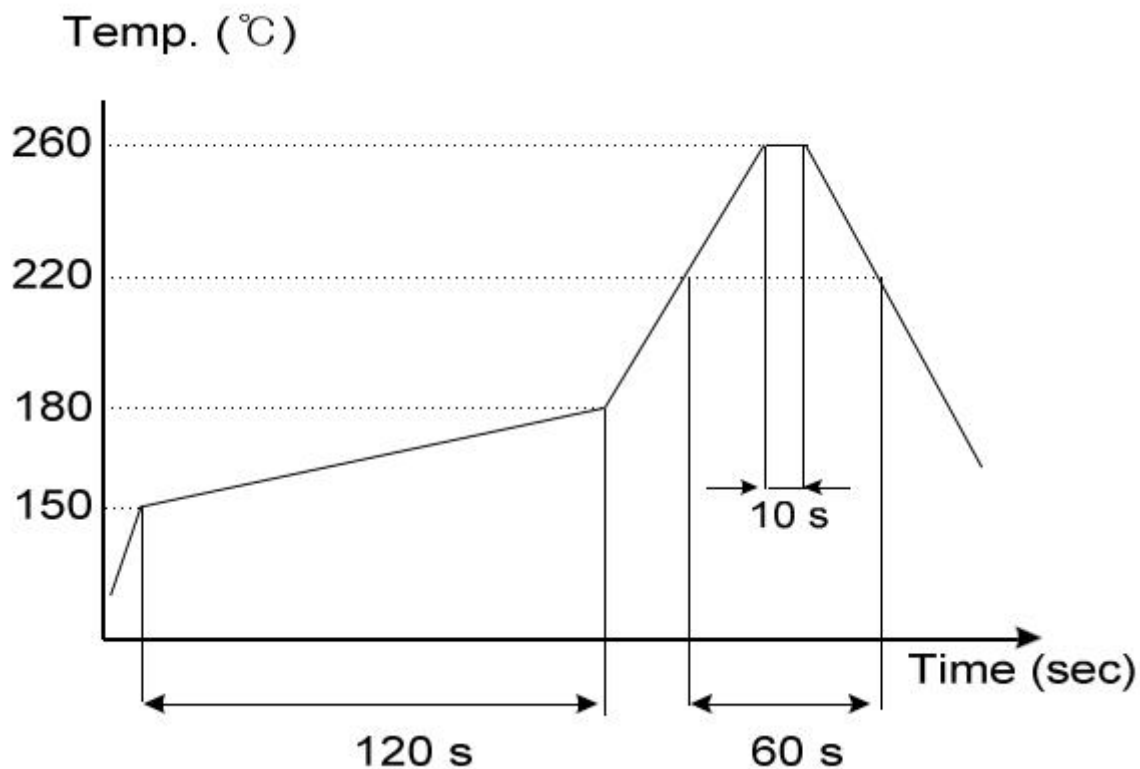
times the frequency being tested.



■ SUGGESTED REFLOW PROFILE

Total time : 200 sec. Max.

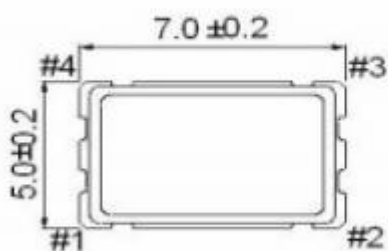
Solder melting point :220 °C



■ PRODUCT DIMENSIONS

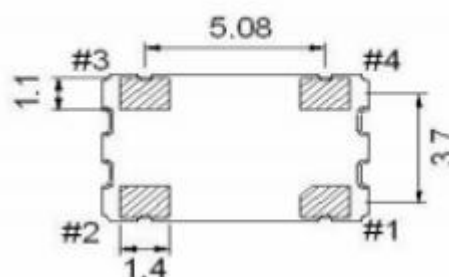
(Unit:mm)

[TOP VIEW]

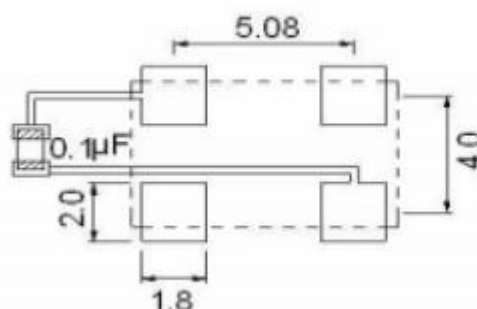
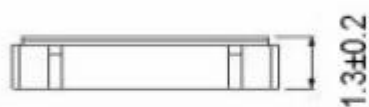


[BOTTOM VIEW]

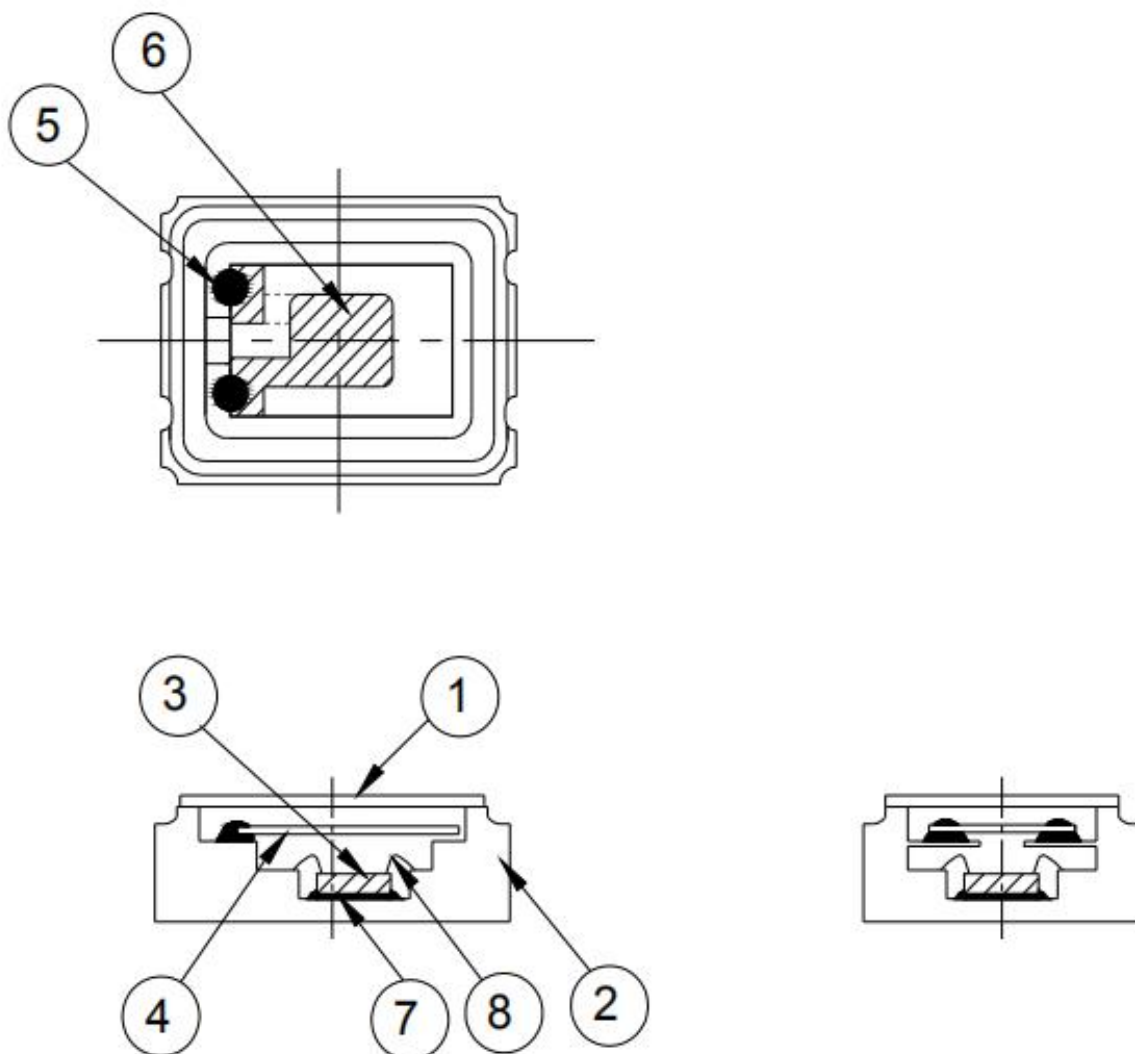
Unit:mm



[SIDE VIEW]



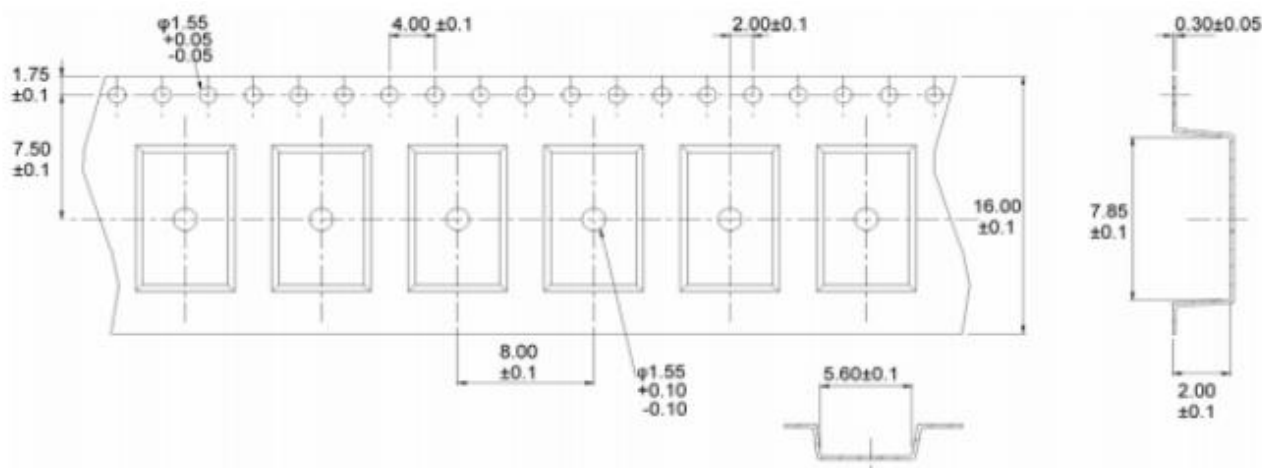
■ STRUCTURE ILLUSTRATION



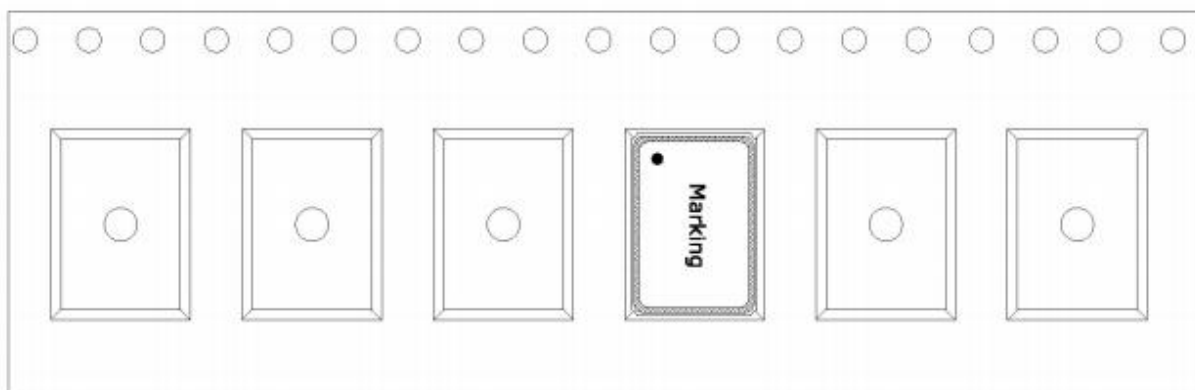
NO	COMPONENTS	MATERIA LS	FINISH/SPECIFICATIONS
1	Lid	Kovar (Fe/Co/Ni)	-
2	Base (Package)	Ceramic (Al ₂ O ₃) + Kovar (Fe/Co/Ni)+Pad (Au)	-
3	IC chip	-	-
4	Crystal blank	SiO ₂	-
5	Conductive adhesive	Ag	Silicon resin
6	Electrode	Noble Metal	-
7	Die attached	Conductive (Ag)	Epoxy resin
8	Bonding wire	Au	Pad 1 options : NC is 5 wires , EN is 6 wires.

■ PACKAGE INFORMATION

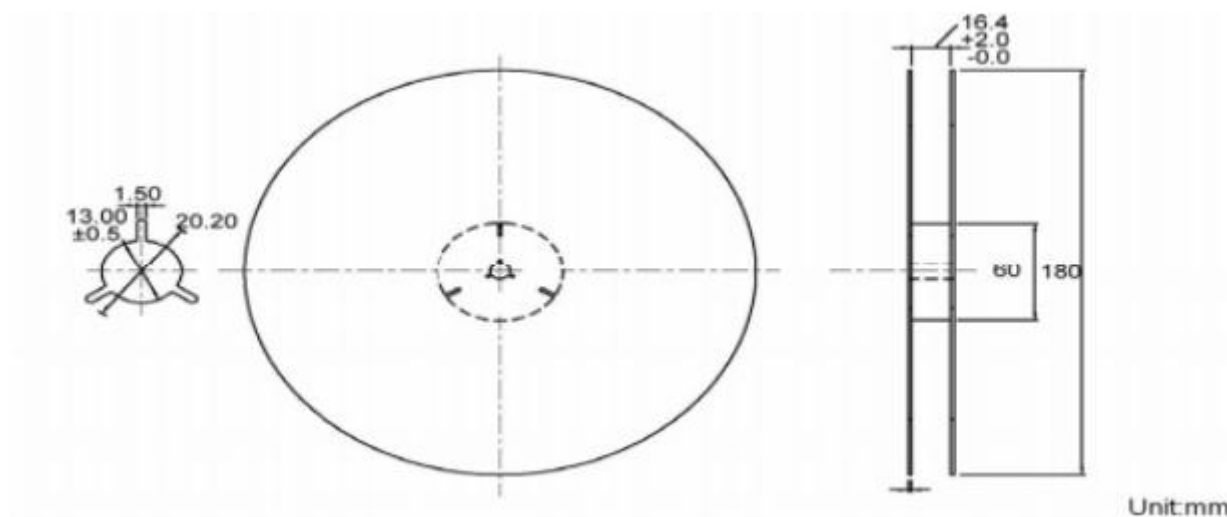
► TAPE (CARRIER) DIMENSIONS



► THE DIRECTION OF PACKING



► REEL DIMENSIONS

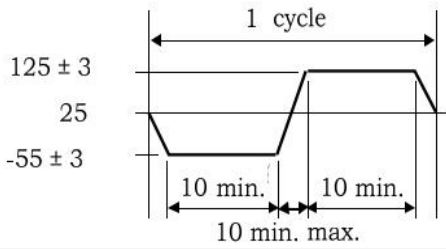


■ RELIABILITY SPECIFICATIONS

1. Mechanical Endurance

No.	Test Item	Test Methods	REF. DOC
1	Drop Test	75 cm height, 3 times on concrete floor .	JIS C6701
1	Mechanical Shock	Device are shocked to half sine wave (1000 G) three mutually perpendicular axes each 3 times. 0.5m sec. duration time	MIL-STD-202
1	Vibration	Frequency range 10 ~ 2000 Hz Amplitude 1.52 mm/20G Sweep time 20 minutes perpendicular axes each test time 4 Hrs (Total test time 12 Hrs)	MIL-STD-883
1	Gross Leak	Standard Sample For Automatic Gross Leak Detector, Test Pressure: 2kg / cm ²	MIL-STD-883
2	Fine Leak	Helium Bomging 4.5 kgf / cm ² for 2 Hrs	MIL-STD-883
2	Solderability	Temperature 245 °C ± 5°C Immersing depth 0.5 mm minimum Immersion time 5 ± 1 seconds Flux Rosin resin methyl alcohol solvent (1 : 4)	MIL-STD-883

2. Environmental Endurance

No.	Test Item	Test Methods	REF. DOC
2	Resistance To Soldering Heat	Pre-heat temperature 125 °C Pre-heat time 60 ~ 120 sec. Test temperature 260 ± 5 °C Test time 10 ± 1 sec.	MIL-STD-202
2	High Temp. Storage	+ 125 °C ± 3 °C for 1000 ± 12 Hrs	MIL-STD-883
2	Low Temp. Storage	- 40 °C ± 3 °C for 1000 ± 12 Hrs	
2	Thermal Shock	Total 100 cycles of the following temperature cycle 	MIL-STD-883
3	High Temp & Humidity	85°C ± 3°C, RH 85% , 1000 Hrs	EIA-JESD22
3	Pressure Cooker Storage	121 ± 3°C , RH100% , 2 bar , 240 Hrs	EIA-JESD22